Long-wavelength 640x484 GaAs/Al_xGa_{1-x}As Quantum Well Infrared Photodetector Focal Plane Array Camera

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ABSTRACT

A 9 μm cutoff 640x484 hand-held quantum well infrared photodetector (QWIP) camera has been demonstrated. Excellent imagery, with a noise equivalent differential temperature (NE ΔT) of 43 mK has been achieved. In this paper, we discuss the development of this very sensitive long wavelength infrared (LWIR) camera based on a GaAs/AlGaAs QWIP focal plane array (FPA) and its performance in quantum efficiency, NE ΔT , uniformity, and operability.

KEYWORDS: Intersubband Transitions, Infrared (IR), Long-wavelength Infrared (LWIR), Gallium Arsenide (GaAs), Quantum WellInfrared Photodetector (QWIP), Focal Plane Arrays, Noise Equivalent Temperat ure Difference (NEAT), Infrared Imaging Cameras

INTRODUCTION

Fabricated entirely from large bandgap materials which are easy to grow and process, it is now possible to obtain large uniform focal plane arrays (FPAs) of QWIPs tuned to detect light at wavelengths from 6 to 25 µmin the GaAs/Al, Ga, As material system [14]. Improving QWIP performance depends largely on minimizing the parasitic current that plagues all light detectors, the dark current (the current that flows through a biased detector in the dark, i.e., with no photons impinging onit). As we have discussed elsewhere [5.6], at temperatures above 45 K, the dark current of the QWIPs having cutoff wavelengths in the 8-12 µm spectral region are entirely dominated by classic thermionic emission of ground state electrons into the energy continuum. Minimizing this dark current component is critical to the commercial success of the QWIP as it allows the highly-desirable high-temperature camera operation.

Therefore, we have designed the bound-to-quasibound quantum well by placing the first excited state exactly at the well top. The previous QWIPs were called the hind-to-continuum, because the first excited state was acontinuum energy band above the well top (typically 10 meV). Dropping the first excited state to the well top causes the barrier to thermionic emission (roughly the energy heightfrom the ground stare to the well top) to be 10 meV more in our bound-to-quasibound QWIP than in the bound-ro-continuum one, theoretically causing the dark current to drop by a factor of - 6 at a temperature of 70 K[5-7]. The dark current-voltage curve of the 8.3 µm peaked bound-to-quasibound QWIP is shown in Figure 1, This compares well with the factor of - 6 drop we have expected from the theoretical estimations.

TEST STRUCTURE RESULTS

Each period of the multi-quantum well (MQW) structure consists of a 45 Å well of Ga As (doped

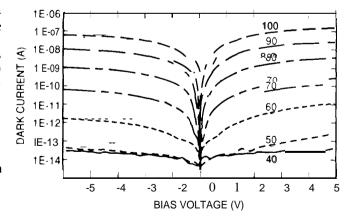
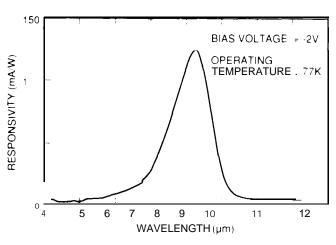


Figure 1. Dark (urrent-voltage curves of 8.3 μ m peaked—bound-to-quasibound attemperatures from 1 = 40-100" K. Datawere taken with a .?() () μ m diameter test structure and normal ized to 18 M8 μ m pixel

 $n \sim 5 \times 10^{17} \text{ cm}^{-3}$) and a 500 Å barrier of Al_{0.3}Ga_{0.7}As. Stacking identical quantum wells (typically 50) together increases photon absorption. Ground state electrons are provided in the detector by doping the GaAs well layers with Si. This photosensitive MQW structure is sandwiched between 0.5 μ m GaAs top and bottom contact layers doped n = 5×10^{17} cm⁻³, grown on a semi-insulating GaAs substrate by molecular beam epitaxy (MBE). Then a 0.7 μ m thick GaAs cap layer on top of a 300 Å Alo 3Gao 7As stop-etch layer was grown in situ on top of the device structure to fabricate the light coupling optical cavity. The MBE grown QWIP structure was processed into 200 μ m diameter mesa test structures (area = 3.14 \times 10⁻⁴ cm²) using wet chemical etching, and Au/Ge ohmic contacts were evaporated onto the top and bottom contact layers.

The detectors were back illuminated through a 45° polished facet [5] and a responsivity spectrum is shown in Figure 2. The responsivity of the detector peaks at 8.3 μm and the peak responsivity ($m R_p$) of the detector is 124 mA/W. at bias $V_B = -2 \text{ V}$. The spectral width and the cutoff wavelength are $\Delta \lambda \lambda = 10\%$ and $\lambda = 8.8 \mu m$ respectively. The bias dependent peak responsivity of the detector was measured, and it is small, up to about $V_B = -$ 0.5 V. Beyond that it increases nearly linearly with bias reaching Rp = 179 mA/W at $V_B = -5 \text{ V}$. This type of behavior of responsivity versus bias is typical for a boundto-quasibound QWIP. The peak quantum efficiency was 17.5°c at bias VB = -2 V for a 45° double pass. The lower quantum efficiency is due to the lower well doping density (5x l() " cm³) as it is necessary to suppress the dark current at the highest possible operating temperature. A peak Figure 2 Responsitivy spectrum of d bound-to-quasibound (WIR achieved with regular well doping density (i.e., 1x10¹⁸ cm). Due to lower readout multiplexer well depth (i.e., 9x10⁶



quantum efficiency as high as 25% has already been QWIP test structure at temperature T = 77 KThe spectral response peak is at 8.3 µm and the long wavelength cutoff is at 8.8 µm

electrons) a lower dark current is mandatory to achieve a higher operating temperature. In this case, [he highest operating temperature of 70 K was determined by the cooling capacity of the liquid nitrogen laboratory dewar. The operating temperature of 70 K has been achieved by pumping on liquid nitrogen.

The photoconductive gaing was experimentally determined using $|g| = i_n^2 / 4eI_DB + 1/2N$, where B is the measurement bandwidth. N is the number of quantum wells, and in is the current noise, which was measured using a spectrum analyzer. The photoconductive gain Of the detector reached 0.98 at V_B=-5V. Since the gain of QWIP is inversely proportional to the number of quantum wells N, the better comparison would be the well capture probability p, which is directly related to the $gain^{(8)}$ by g=1/Npc. The calculated well capture probabilities are 25% at low bias (i.e., VB=-1/V) and 2% at high bias (i. e., VB=-5/V) which indicate the excellent hot-electron transport in this device structure. The peak detectivity is defined as $D_p^* = R_p \sqrt{AB} / i_p$, where Rp is the peak responsivity. The measured peak detectivity at bias V_B = -3.() V and temperature T = 70 K is $1.8 \times 101 \text{ l}_{\text{Cm}} \text{ /Hz/W}$. These detectors show background limited performance (BLIP) at bias $V_B = -2V$ and temperature T = 73 K for 300 K background with f/2 optics,

QWIP IMAGING FOCALPLANE ARRAYS

1[is wellknown that QWIPS do not absorb radiation incident normal to the surface unless the IR radiation has an electric field component normal to the layers of superlattice (growth direction) [5]. As we have discussed before [5,9] more IR light can be coupled to the QWIP detector structure by incorporating a two dimensional grating surface on top of the detectors which also removes the light coupling limitations and makes two dimensional QWIP imaging arrays feasible. This two dimensional grating structure was fabricated on the detectors by using standard photolithography and CCl₂F₂ selective dr! etching.

After the 2-D grating array was defined by the photolithography and dry etching, the photoconductive QWIPs of the 640x484FPAs were fabricated by wet chemical etching through the photosensitive GaAs/Al_xGa_{1-x}As multi-quantum well layers into [he 0.5 µm thick doped GaAs bottom contact layer. The pitch of the FPA is 25µm and the actual pixel size is $18x18\mu m^2$. The cross gratings on top of the detectors were then covered with Au/Ge and Au for Ohmic contact and reflection. Figure 3 shows twelve processed QWIP FPAs on a 3 inch. GaAs wafer. Indium bumps were then evaporated on top of the detectors for Sire adout circuit (ROC) hybridization. A single QWIP FPA was chosen and hybridized (via indium bump-bonding process) to a 640x484 CMOS multiplexer (Amber Al{-181}) and biased at $V_B = -2.0 \text{ V}$. Figure 4 shows a size comparison of this large arealong-wavelength QWIP FPA to a quarter. At temperatures below 70 K, the signal to noise ratio

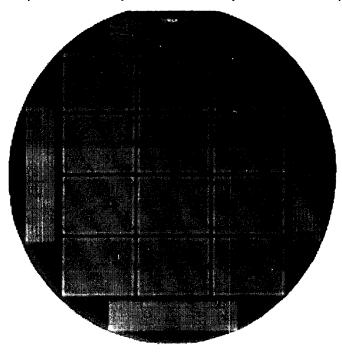


Figure 3. Twelve 640 x 484 QWIP focal plane arrays on a 3 in. GaAs wafer.



Figure 4. A size comparison of the 640 χ 484 long-way elength QWIP FPA to a quarter.

of the system is limited by array non-uniformity, multiplexer readout noise, and photocurrent (photon flux) noise. At temperatures above 70 K, temporal noise due to the QWIP's higher dark current becomes the limitation. As mentioned earlier this higher dark current is due to thermionic emission and thus causes the charge storage capacitors of the readout circuitry to saturate. Since the QWIP is a high impedance device, it should yield a very high charge injection coupling efficiency into the integration capacitor of the multiplexer. In fact Bethea et al.[2] have demonstrated charge injection efficiencies approaching 90%. Charge injection efficiency can be obtained from [3]

$$\eta_{inj} = \frac{g_{m}R_{Det}}{1 + g_{m}R_{Det}} \left[-\frac{1}{1 + j\omega C_{Det}} R_{Det} \right] \\
+ \frac{1}{1 + g_{m}R_{Det}} (1)$$

where $g_{\rm III}$ is the transconductance of the MOSFET and it is given by $g_{\rm III} = eI_{\rm DeI}/kT$. The differential resistance $R_{\rm DeI}$ of the pixels at -2 V bias is 5.4×10^{10} Ohms at T= 70 K and detector capacitance CDet is 1.4×10^{14} F. The detector dark current lDet = 24 pA under the same operating conditions. According to equation (I) the charge injection efficiency $\eta_{\rm inj} = 99.5\%$ at a frame rate of 30 1 lz. The FPA was back-illuminated through the flat thinned substrate membrane (thickness $\approx 1300^\circ$ Å). This thinned GaAs FPA membrane has completely eliminated the thermal mismatch between the silicon CMOS readout multiplexer and the GaAs based Q\\\' II' FPA. Basically, the thinned GaAs based QWIP FPA membrane adapts the thermal expansion and contraction coefficients of the silicon readout multiplexer. '1'here' fore, this thinning has played an extremely important role in the fabrication of large area FPA hybrids. In addition, this thinning has completely eliminated the pixel-to-pixel cross talk of the f'TA. This initial array gave excellent images with 99% of the pixels working, demonstrating the high yield of GaAs technology. The operability was defined as the percentage of pixels having noise equivalent differential temperature less than I ()() mK at 300° K background and in this case operability happens to be equal to the pixel yield.

We have used the following equation to calculate the noise equivalent temperature difference (NEAT) of the FPA.

NEAT =
$$D_{B}^{*}(dP_{B}/dT)\sin^{2}(\theta/2)$$
 (2)

where D_B^2 is the blackbody detectivity, dP_B/dT is the derivative of the integrated blackbody power with respect to temperature, and θ is the field of view angle [i.e., $\sin^2(\theta/2) = (4f^2+1)^{-1}$, where f is the f number of the optical system]. The background temperature $T_B = 300$ K, the area of the pixel $A = (18 \ \mu m)^2$, the f number of the optical system is 2.3, and the frame rate is 30 Hz. Figure 5 shows the experimentally measured NEAT of the FPA at an operating temperature of T = 70 K, bias $V_B = -2$ V for 300 K background and the mean value is 43 mK. This agrees reasonably with our estimated value of 25 mK based on test structure data. The experimentally measured peak quantum efficiency of the FPA was 2.3% (lower focal plane array quantum efficiency is attributed to 51% fill factor and 30% reflection loss from the GaAs back surface). Therefore, the corrected quantum efficiency of a focal plane detectors is 6.5% and this corresponds to an average of one pass of IR radiation (equivalent to a single 45° pass) through the photosensitive multi-quantum well region.

FOCAL PLANE ARRAY CAMERA

A 640X484 QWIP FPA hybrid was mounted onto a 84-pin lead-less chip carrier and installed into laboratory dewar which can be cooled by liquid nitrogen, to demonstrate a LWIR imaging camera. The other element of the camera is a 100 mm focal length AR coated germanium lens, which gives a $9.2^{\circ}x6.9^{\circ}$ field of view. It is designed to be transparent in the 8-12 μ m wavelength range, to be compatible with the QWIP's 8-9 μ m operation. The digital acquisition resolution of the camera is 12-bits, which determines the instantaneous dynamic range of the camera (i.e., 4096). However, the dynamic range of QWIP is 85 Decibels.

The measured mean NE Δ T of the QWIP camera is 43 mK at an operating temperature of T = 70 K and bias V_B = -2 V, for a 300 K background. The uncorrected NE Δ T non-uniformity (which includes a 1% non-uniformity of the ROC and a 1.4% non-uniformity due to the cold-stop in front of the FPA not yielding the same field of view to all the pixels) of the 309,760 pixels of the 640x484 FPA is about 10% (= sigma/mean). Figure 6 shows the noise histogram of this first unoptimized 640x484 QWIP.FPA. The non-uniformity after two-point (17° and 27° Celsius) correction improves to an impressive 0.1%. As mentioned earlier, this high yield is due to the excellent GaAs growth uniformity and the mature GaAs processing technology.

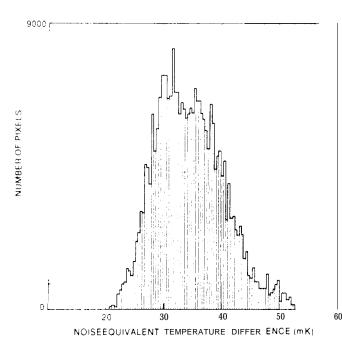


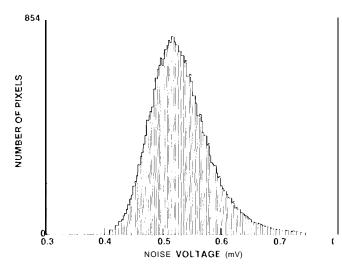
Figure 5. Noise equivalent temperature difference (NEAT) histogram of the 309.760 pixels of the 640 x 484 array showing a high uniformity of the FPA. The uncorrected non-uniformity (= standard deviation mean) of this unoptimized FPA is only 10% including 1% non-uniformity of ROC and 1.4% non-uniformity due to the cold-stop not being able to give the same field of view to all the pixels in the FPA.

Video images were taken at a frame rate of 30 Hz at temperatures as high as $T=70~\rm K$, using a ROC capacitor having a charge capacity of $9x10^6$ electrons (the maximum number of photoelectrons and dark electrons that can be counted in the integration time of each detector pixel). Figure 7 (a) and (b) show two frames of video image taken with this long-wavelength 640x484 QWIP camera. Figure 7(a) shows a man's face with a warm mustache which was heated by a hot air blower. It also shows the hot air emanating from the air blower. Figure 7(b) shows a cold hand of a person who momentarily touched a cold soda can. These images demonstrate the high sensitivity of the 640x484 long-wavelength QWIP staring array camera.

It should be noted that these initial unoptimized FPA results are far from optimum. The light coupling gratings were not optimized (as describe dearlier) for maximum light coupling efficiency; no anti-reflection coatings were used on the backside of the FPA; and finally the multiplexer used was not optimized to supply the proper bias required by photoconductive QWIPs (i.e., AE-18 I was optimized for photovoltaic lnSb FPAs). Implementation of these improvements should significantly enhance the QWIP FPA operating temperature (i.e., 77 K for 9 µm).

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Ligure 6. Noise histogram of the 640 x 484 long-wavelength QWIP FPA. The noise uniformity of this first unoptimized FPA is about 11% before corrections.

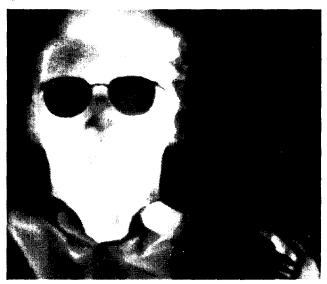




Figure 7(a). A man's face with a warm mustache which was heated by a hot air blower. It also shows the hot air emanating from the air blower. Figure 7(b) shows a cold hand of a person who momentarily held a cold soda can. These images demonstrate the high sensitivity of the 640 x 484 long-wavelength QWIP staring array camera.

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